## Quad 2-Input NAND Gates

## DESCRIPTION

The 74 HC 00 contain four independent, 2-input NAND gates. They perform the Boolean function $\mathrm{Y}=\overline{\mathrm{A}} \times \overline{\mathrm{B}}$ or $\mathrm{Y}=\overline{\mathrm{A}}+\overline{\mathrm{B}}$ in positive logic. Inputs include clamp diodes.

## APPLICATIONS

- AV Receivers
- Portable Audio Docks
- Blu-ray Players and Home Theater
- Wireless Devices


## ORDERING INFORMATION

| Device | Package |
| :---: | :---: |
| 74 HC 00 D | SOP-14L |

## FEATURES

- Wide Operating Voltage Range of 2.0 V to 6.0 V
- Outputs Can Drive up to 10 LSTTL Loads
- Low Power Consumption, $20 \mu \mathrm{~A}$ Maximum Icc
- Typical tpd: 8ns
- $\pm 4 \mathrm{~mA}$ Output Drive at 5.0 V
- Low Input Current of $1 \mu \mathrm{~A}$ Maximum

SOP-14L

ABSOLUTE MAXIMUM RATINGS (Note 1)

| CHARACTERISTIC |  | SYMBOL | MIN. | MAX. | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: |
| DC Supply Voltage |  | $\mathrm{V}_{\mathrm{CC}}$ | -0.5 | 7.0 | V |
| Input Clamp Current (Note 2) | $\mathrm{V}_{\mathrm{I}}<0$ or $\mathrm{V}_{\mathrm{I}}>\mathrm{V}_{\mathrm{CC}}$ | $\mathrm{I}_{\text {IK }}$ | - | $\pm 20$ | mA |
| Output Clamp Current (Note 2) | $\mathrm{V}_{\mathrm{O}}<0$ | $\mathrm{I}_{\mathrm{OK}}$ | - | $\pm 20$ | mA |
| Continuous Output Current | $\mathrm{V}_{\mathrm{O}}=0$ to $\mathrm{V}_{\mathrm{CC}}$ | $\mathrm{I}_{\text {IN }}$ | - | $\pm 25$ | mA |
| Continuous Current through $\mathrm{V}_{\text {CC }}$ or GND |  |  | - | $\pm 50$ | mA |
| Maximum Junction Temperature |  | $\mathrm{T}_{\mathrm{J}}$ | - | 150 | ${ }^{\circ} \mathrm{C}$ |
| Storage Temperature |  | $\mathrm{T}_{\text {STG }}$ | -65 | 150 | ${ }^{\circ} \mathrm{C}$ |

Note 1. Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device.
These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Conditions is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

Note 2. The input and output negative-voltage ratings may be exceeded if the input and output clamp current ratings are observed.

## RECOMMENDED OPERATING CONDITIONS (Note 3)

| CHARACTERISTIC | SYMBOL | MIN. | MAX. | UNIT |
| :--- | :---: | :---: | :---: | :---: |
| Supply Voltage | $\mathrm{V}_{\mathrm{CC}}$ | 2.0 | 6.0 | V |
| DC Input Voltage | $\mathrm{V}_{\mathrm{IN}}$ | 0 | $\mathrm{~V}_{\mathrm{CC}}$ | V |
| DC Output Voltage | $\mathrm{V}_{\mathrm{OUT}}$ | 0 | $\mathrm{~V}_{\mathrm{CC}}$ | V |
| Operating Free-Air Temperature Range | $\mathrm{T}_{\mathrm{A}}$ | -40 | 85 | ${ }^{\circ} \mathrm{C}$ |

Note 3. The device is not guaranteed to function outside its operating ratings.

PIN CONFIGURATION


BLOCK DIAGRAM


## PIN DESCRIPTION

| Pin No. | Pin Name | Pin Function |
| :---: | :---: | :---: |
| SOP-14L |  |  |
| 1 | 1A | Input 1A |
| 2 | 1B | Input 1B |
| 3 | 1 Y | Output 1 |
| 4 | 2A | Input 2A |
| 5 | 2B | Input 2B |
| 6 | $2 Y$ | Output 2 |
| 7 | GND | Ground |
| 8 | 3 Y | Output 3 |
| 9 | 3A | Input 3A |
| 10 | 3B | Input 3B |
| 11 | 4 Y | Output 4 |
| 12 | 4A | Input 4A |
| 13 | 4B | Input 4B |
| 14 | VCC | Power Supply |

## ORDERING INFORMATION

| Package | Order No. | Description | Supplied As | Status |
| :---: | :---: | :---: | :---: | :---: |
| SOP-14L | 74 HC 00 S 14 | Quad 2-Input NAND Gates | Tape \& Reel | Active |

## Note:

$>74 \mathrm{HCO} \mathrm{S} 14$ devices are Pb-free and RoHS compliant.
$>$ The surface prints of our semiconductor devices are subject to change during the production process and do not involve changes in electrical parameters, and we will not separately state the notice.
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ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.


## Note:

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A Update by Apr. 2018

